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## FDS6680S

## 30V N-Channel PowerTrench® SyncFET™

### **General Description**

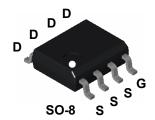
The FDS6680S is designed to replace a single SO-8 MOSFET and Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $R_{\rm DS(ON)}$  and low gate charge. The FDS6680S includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology. The performance of the FDS6680S as the low-side switch in a synchronous rectifier is indistinguishable from the performance of the FDS6680 in parallel with a Schottky diode.

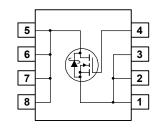
## **Applications**

- DC/DC converter
- · Motor drives

#### **Features**

- 11.5 A, 30 V.  $R_{DS(ON)} = 0.011 \Omega @ V_{GS} = 10 V$  $R_{DS(ON)} = 0.017 \Omega @ V_{GS} = 4.5 V$
- Includes SyncFET Schottky body diode
- Low gate charge (17nC typical)
- High performance trench technology for extremely low R<sub>DS(ON)</sub> and fast switching
- High power and current handling capability





Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

| Symbol                            | Parameter  |           | Ratings     | Units |
|-----------------------------------|--|-----------|-------------|-------|
| V <sub>DSS</sub>                  | Drain-Source Voltage                             |           | 30          | V     |
| V <sub>GSS</sub>                  | Gate-Source Voltage                              |           | ±20         | V     |
| I <sub>D</sub>                    | Drain Current - Continuous                       | (Note 1a) | 11.5        | А     |
|                                   | – Pulsed   | Ī         | 50          |       |
| P <sub>D</sub>                    | Power Dissipation for Single Operation           | (Note 1a) | 2.5         | W     |
|                                   |  | (Note 1b) | 1.2         |       |
|                                   |  | (Note 1c) | 1           |       |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature Range |           | -55 to +150 | °C    |

## **Thermal Characteristics**

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 50 | °C/W |
|-----------------|---|-----------|----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case    | (Note 1)  | 25 | °C/W |

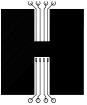
**Package Marking and Ordering Information** 

| Device Marking    | Device | Reel Size | Tape width | Quantity   |
|-------------------|--------|-----------|------------|------------|
| FDS6680S FDS6680S |        | 13"       | 12mm       | 2500 units |

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| Symbol                                | Parameter   | Test Conditions   | Min | Тур               | Max            | Units |
|---------------------------------------|---|---|-----|-------------------|----------------|-------|
| Off Char                              | acteristics                                       |   |     | I                 | I              | I     |
| BV <sub>DSS</sub>                     | Drain-Source Breakdown Voltage                    | $V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$  | 30  |                   |                | V     |
| ΔBV <sub>DSS</sub><br>ΔT <sub>J</sub> | Breakdown Voltage Temperature Coefficient         | I <sub>D</sub> = 1 mA, Referenced to 25°C   |     | 19                |                | mV/°C |
| I <sub>DSS</sub>                      | Zero Gate Voltage Drain Current                   | V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V   |     |                   | 500            | μА    |
| I <sub>GSSF</sub>                     | Gate-Body Leakage, Forward                        | V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V   |     |                   | 100            | nA    |
| I <sub>GSSR</sub>                     | Gate-Body Leakage, Reverse                        | $V_{GS} = -20 \text{ V},  V_{DS} = 0 \text{ V}$   |     |                   | -100           | nA    |
| On Char                               | acteristics (Note 2)                              | •   |     |                   |                |       |
| $V_{GS(th)}$                          | Gate Threshold Voltage                            | $V_{DS} = V_{GS}$ , $I_D = 1 \text{ mA}$  | 1   | 2                 | 3              | V     |
| $\Delta V_{GS(th)} \over \Delta T_J$  | Gate Threshold Voltage<br>Temperature Coefficient | I <sub>D</sub> = 1 mA, Referenced to 25°C   |     | -3.3              |                | mV/°C |
| R <sub>DS(on)</sub>                   | Static Drain–Source<br>On–Resistance              | $V_{GS} = 10 \text{ V}, \qquad I_D = 11.5 \text{ A}$<br>$V_{GS} = 4.5 \text{ V}, \qquad I_D = 9.5 \text{ A}$<br>$V_{GS} = 10 \text{ V}, I_D = 11.5 \text{ A}, T_J = 125 ^{\circ}\text{C}$ |     | 9.5<br>13.5<br>17 | 11<br>17<br>23 | mΩ    |
| I <sub>D(on)</sub>                    | On-State Drain Current                            | V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V   | 50  |                   |                | Α     |
| <b>g</b> <sub>FS</sub>                | Forward Transconductance                          | $V_{DS} = 15 \text{ V}, \qquad I_{D} = 11.5 \text{ A}$  |     | 27                |                | S     |
| Dynamic                               | Characteristics                                   | •   |     |                   |                |       |
| C <sub>iss</sub>                      | Input Capacitance                                 | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V,  |     | 2010              |                | pF    |
| Coss                                  | Output Capacitance                                | f = 1.0 MHz   |     | 526               |                | pF    |
| C <sub>rss</sub>                      | Reverse Transfer Capacitance                      |   |     | 186               |                | pF    |
| Switchin                              | g Characteristics (Note 2)                        | •   |     |                   |                |       |
| t <sub>d(on)</sub>                    | Turn-On Delay Time                                | $V_{DS} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A},$  |     | 10                | 18             | ns    |
| t <sub>r</sub>                        | Turn-On Rise Time                                 | $V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$  |     | 10                | 18             | ns    |
| $t_{d(off)}$                          | Turn-Off Delay Time                               |   |     | 34                | 55             | ns    |
| t <sub>f</sub>                        | Turn–Off Fall Time                                | 7   |     | 14                | 23             | ns    |
| Qg                                    | Total Gate Charge                                 | $V_{DS} = 15 \text{ V}, \qquad I_{D} = 11.5 \text{ A},$   |     | 17                | 24             | nC    |
| Q <sub>gs</sub>                       | Gate-Source Charge                                | V <sub>GS</sub> = 5 V   |     | 6.2               |                | nC    |
| $Q_{gd}$                              | Gate-Drain Charge                                 |   |     | 5.5               |                | nC    |
| Drain-S                               | ource Diode Characteristics                       | and Maximum Ratings   |     |                   |                |       |
| I <sub>S</sub>                        | Maximum Continuous Drain-Source                   | Ţ.  |     |                   | 3.5            | Α     |
| V <sub>SD</sub>                       | Drain–Source Diode Forward<br>Voltage             | $V_{GS} = 0 \text{ V},  I_S = 3.5 \text{ A}  \text{(Note 2)}$<br>$V_{GS} = 0 \text{ V},  I_S = 7 \text{ A}  \text{(Note 2)}$  |     | 0.45<br>0.6       | 0.7            | V     |
| t <sub>rr</sub>                       | Diode Reverse Recovery Time                       | I <sub>F</sub> = 11.5A,   |     | 20                |                | nS    |
| Qrr                                   | Diode Reverse Recovery Charge                     | $d_{iF}/d_t = 300 \text{ A/}\mu\text{s}$ (Note 3)   |     | 19.7              |                | nC    |

<sup>1.</sup>  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 50°/W when mounted on a 1 in² pad of 2 oz copper



b) 105°/W when mounted on a .04 in² pad of 2 oz copper



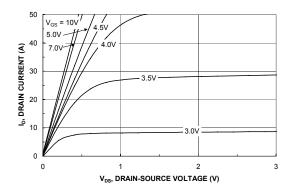
c) 125°/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

- 2. Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%
- $\textbf{3.} \ \mathsf{See} \ \mathsf{``SyncFET} \ \mathsf{Schottky} \ \mathsf{body} \ \mathsf{diode} \ \mathsf{characteristics''} \ \mathsf{below}.$

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## **Typical Characteristics**



2

1.8

Vos = 4.0V

1.4

Vos = 4.0V

1.5

Vos = 4.0V

1.6

0.8

0.10

20

30

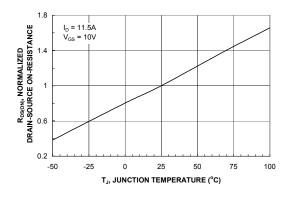
40

50

10, DRAIN CURRENT (A)

Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



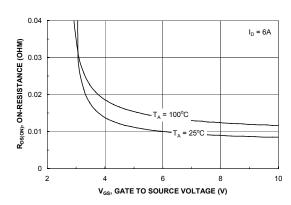
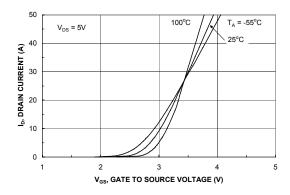


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



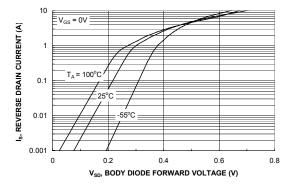
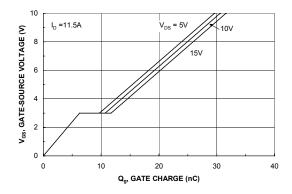


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

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## Typical Characteristics (continued)



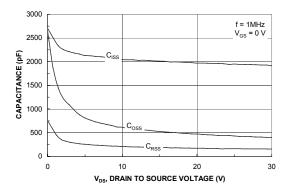
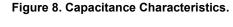
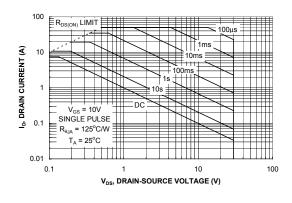


Figure 7. Gate Charge Characteristics.





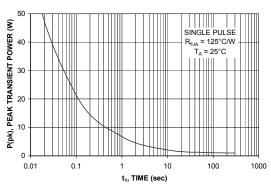


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

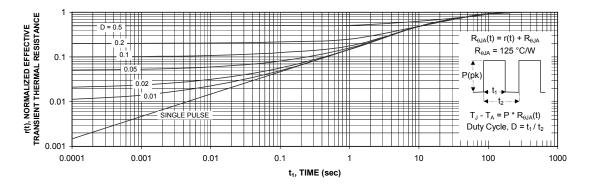


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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## **Typical Characteristics** (continued)

## SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS6680S.

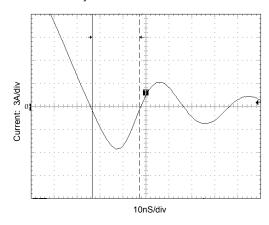


Figure 12. FDS6680S SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6680).

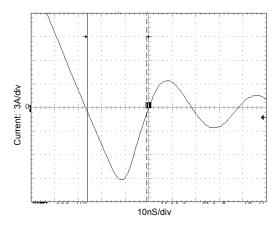


Figure 13. Non-SyncFET (FDS6680) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

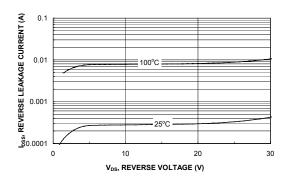


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

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